# MOSFET – Power, Single, N-Channel, μ8FL 30 V, 57 A

### **Features**

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- DC-DC Converters
- High Side Switching

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage	$V_{DSS}$	30	V		
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	13.5	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 85°C	1	9.7	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.1	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	18.6	Α
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 85°C		13.4	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.1	W
Continuous Drain	State	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	7.5	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>C</sub> = 85°C	1	5.4	
Power Dissipation R <sub>0JA</sub> (Note 2)		T <sub>C</sub> = 25°C	P <sub>D</sub>	0.66	W
Continuous Drain		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	57	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C	1	41	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	38.5	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t <sub>p</sub> = 10 μs	$I_{DM}$	171	Α
Operating Junction and S	storage Ten	nperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to +150	°C
Source Current (Body Die	I <sub>S</sub>	38.5	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So $(T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, \text{ I}_L = 33 \text{ A}_{pk}, L = 0.1 \text{ mH}, F$	E <sub>AS</sub>	55	mJ		
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

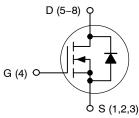


## ON Semiconductor®

## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	7.0 mΩ @ 10 V	57 A
	10.8 mΩ @ 4.5 V	31 A

## **N-Channel MOSFET**





WDFN8 (µ8FL) CASE 511AB FLAT LEAD



4821 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week

= Pb-Free Package
 (Note: Microdot may be in either location)

## ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTTFS4821NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4821NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.25	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	58.3	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	188.4	
Junction–to–Ambient – (t ≤ 10 s) (Note 3)	$R_{ hetaJA}$	30.6	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Conditi	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS			•		•		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				25		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{GS} = 0 V$ , $V_{DS} = 24 V$	T <sub>J</sub> = 125°C			10	<b>1</b>
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 2$	250 μΑ	1.5	1.9	2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>		I <sub>D</sub> = 20 A		5.8	7.0	mΩ
		V <sub>GS</sub> = 10 V to 11.5 V	I <sub>D</sub> = 10 A		5.7		1
			I <sub>D</sub> = 20 A		8.8	10.8	1
		$V_{GS} = 4.5 V$	I <sub>D</sub> = 10 A		8.6		1
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A			53		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>				1300	1755	pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V			300	405	
Reverse Transfer Capacitance	C <sub>rss</sub>				150	233	
Total Gate Charge	Q <sub>G(TOT)</sub>				10.5	15	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V 45VV 45	\/		1.3		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15$	V, I <sub>D</sub> = 30 A		3.9		
Gate-to-Drain Charge	$Q_{GD}$				4.5		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 11.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A			24		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t <sub>d(on)</sub>				12		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			22		7
Turn-Off Delay Time	t <sub>d(off)</sub>				16		
Fall Time	t <sub>f</sub>				4.5		1
					_		

- 5. Pulse Test: pulse width = 300  $\mu$ s, duty cycle  $\leq$  2%.
  6. Switching characteristics are independent of operating junction temperatures.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note 6)		•			•	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			8.5		ns
Rise Time	t <sub>r</sub>				20		]
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 15 \text{ A}, R_G =$	3.0 Ω		23		]
Fall Time	t <sub>f</sub>	1			2.8		
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $T_J = 25^{\circ}\text{C}$		0.9	1.0	V	
		I <sub>S</sub> = 20 A	T <sub>J</sub> = 125°C		0.78		
Reverse Recovery Time	t <sub>RR</sub>		•		9.0		ns
Charge Time	ta	$V_{GS} = 0 \text{ V},$ $d_{IS}/d_t = 100 \text{ A/}\mu\text{s},$ $I_S = 20 \text{ A}$			6.5		
Discharge Time	t <sub>b</sub>				2.5		
Reverse Recovery Charge	Q <sub>RR</sub>				1.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.38		nH
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.054		
Gate Inductance	L <sub>G</sub>				1.3		
Gate Resistance	$R_{G}$				0.6	2.0	Ω

<sup>5.</sup> Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**

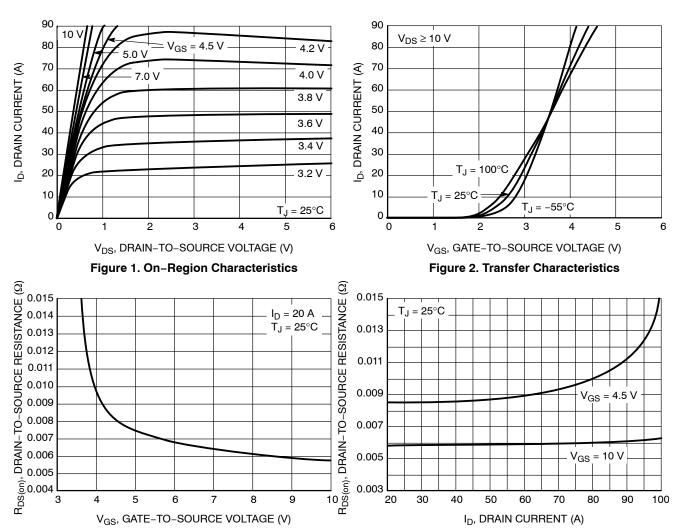


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

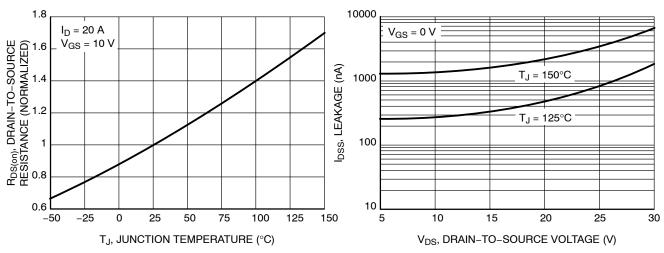


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

## **TYPICAL CHARACTERISTICS**

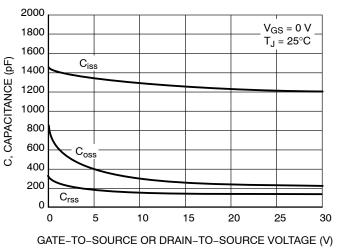


Figure 7. Capacitance Variation

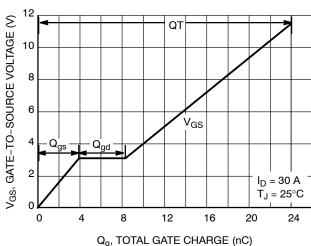
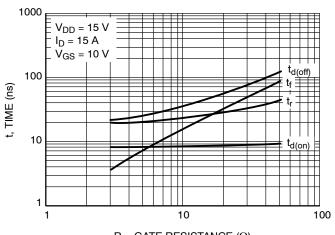


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



 $\label{eq:RG} \textbf{R}_{\textbf{G}}, \, \textbf{GATE} \, \, \textbf{RESISTANCE} \, (\Omega)$  Figure 9. Resistive Switching Time Variation

vs. Gate Resistance

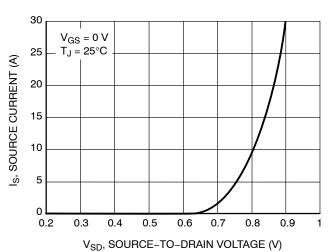


Figure 10. Diode Forward Voltage vs. Current

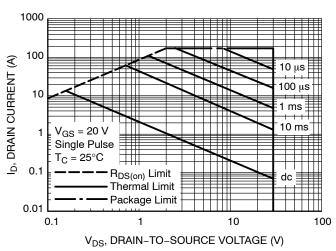


Figure 11. Maximum Rated Forward Biased Safe Operating Area

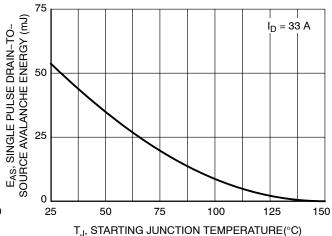


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature



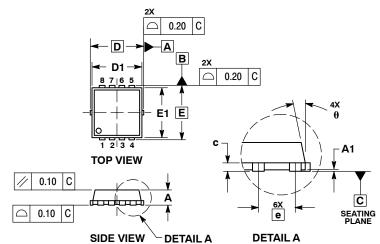




SCALE 2:1

## WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	)	
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC			0.026 BS0	)
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

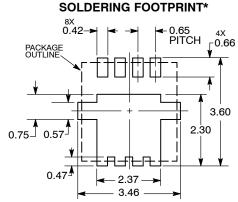


## **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code Α = Assembly Location

= Year = Work Week WW = Pb-Free Package



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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